## UNITED STATES PATENT AND TRADEMARK OFFICE CERTIFICATE OF CORRECTION

PATENT NO. : 6,548,912 B1 Page 1 of 1

DATED : April 15, 2003 INVENTOR(S) : Graff et al.

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

## Column 14,

Line 35, add the following claims:

- 57. The encapsulated microelectronic device of claim 46 wherein the two barrier layers are made of different barrier materials.
- 58. The encapsulated microelectronic device of claim 1 wherein the oxygen transmission rate through the at least one first barrier stack is less than 0.005 cc/m2/day at 38°C and 90% relative humidity.
- 59. The encapsulated microelectronic device of claim 1 further comprising an overcoat layer adjacent to the at least one first barrier stack on a side opposite the microelectronic device.
- 60. The encapsulated microelectronic device of claim 1 wherein the overcoat layer is selected from organic layers, inorganic layers, planarizing layers, transparent conductors, antireflective coatings, or combinations thereof.

Signed and Sealed this

Tenth Day of August, 2004

JON W. DUDAS
Acting Director of the United States Patent and Trademark Office